

STL285N4F7AG

Automotive-grade N-channel 40 V, 0.9 mΩ typ., 120 A STripFET™ F7 Power MOSFET in a PowerFLAT™ 5x6 package

Datasheet - production data

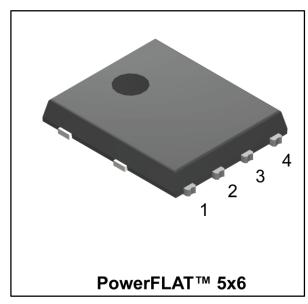
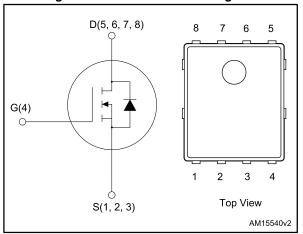


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max	lο
STL285N4F7AG	40 V	1.1 mΩ	120 A

- Designed for automotive applications and AEC-Q101 qualified
- Among the lowest R_{DS(on)} on the market
- Excellent FoM (figure of merit)
- Low C_{rss}/C_{iss} ratio for EMI immunity
- High avalanche ruggedness
- Wettable flank package

Applications

Switching applications

Description

This N-channel Power MOSFET utilizes STripFET™ F7 technology with an enhanced trench gate structure that results in very low onstate resistance, while also reducing internal capacitance and gate charge for faster and more efficient switching.

Table 1: Device summary

Order code	Marking	Package	Packaging
STL285N4F7AG	285N4F7	PowerFLAT™ 5x6	Tape and reel

Contents STL285N4F7AG

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STL285N4F7AG Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	40	V
V_{GS}	Gate-source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	120	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C		Α
I _{DM} ⁽¹⁾⁽²⁾	Drain current (pulsed)	480	Α
Ртот	Total dissipation at $T_C = 25$ °C	188	W
I _{AV}	Avalanche current, repetitive or not repetitive (pulse width limited by maximum junction temperature)		Α
Eas	Single pulse avalanche energy ($T_j = 25$ °C, $I_D = 24$ A, $V_{DD} = 25$ V)	280	mJ
Tj	Operating junction temperature range	-55 to	°C
T _{stg}	Storage temperature range	175	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb max.	31.3	°C/W
R _{thj-case}	Thermal resistance junction-case max.		°C/W

Notes:

 $^{^{(1)}\}mbox{Drain}$ current is limited by package, the current capability of the silicon is 310 A at 25 °C.

⁽²⁾Pulse width limited by safe operating area

 $^{^{(1)}}$ When mounted on FR-4 board of 1 inch², 2oz Cu, t < 10 s.

Electrical characteristics STL285N4F7AG

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4: On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	40			V
I _{DSS}					1	μΑ
I _{GSS}	Gate-body leakage current	V _{GS} = 20 V, V _{DS} = 0 V			100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 24 A		0.9	1.1	mΩ

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance	V 05 V (4 M)	-	5600	ı	pF
Coss	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0 \text{ V}$	-	2400	ı	pF
Crss	Reverse transfer capacitance	VGS= U V		35	ı	pF
Q_g	Total gate charge	$V_{DD} = 20 \text{ V}, I_D = 48 \text{ A},$	-	67	ı	nC
Q_{gs}	Gate-source charge	$V_{GS} = 10 \text{ V}$	-	31	ı	nC
Q _{gd}	Gate-drain charge	(see Figure 14: "Test circuit for gate charge behavior")		9	-	nC

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 20 \text{ V}, I_D = 48 \text{ A},$	ı	30	-	ns
tr	Rise time	$R_G = 4.7 \Omega, V_{GS} = 10 V$	ı	21	-	ns
$t_{d(off)}$	Turn-off delay time	(see Figure 13: "Test circuit for resistive load	-	42	-	ns
t _f	Fall time	switching times" and Figure 18: "Switching time waveform")	-	13	-	ns

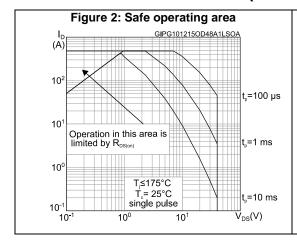
Table 7: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{SD} ⁽¹⁾	Forward on voltage	I _{SD} = 48 A, V _{GS} = 0 V	ı		1.2	V
t _{rr}	Reverse recovery time	I _D = 48 A, di/dt = 100 A/μs	ı	68		ns
Qrr	Reverse recovery charge	$V_{DD} = 32 \text{ V}$	-	98		nC
I _{RRM}	Reverse recovery current	(see Figure 15: "Test circuit for inductive load switching and diode recovery times")	-	2.9		Α

Notes:

 $^{^{(1)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.2 Electrical characteristics (curves)



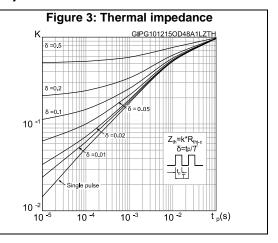


Figure 4: Output characteristics

GIPG1012150D48A1LOCH

(A)

V GS= 6 V

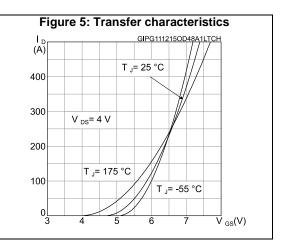
V GS= 7, 8, 9, 10 V

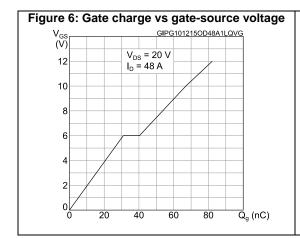
V GS= 5.5 V

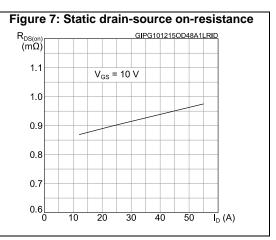
V GS= 5.5 V

O

1 2 3 4 5 V DS(V)







STL285N4F7AG Electrical characteristics

Figure 8: Capacitance variations

C GIPG1012150D48A1LCVR

(pF)

10⁴

C_{ISS}

C_{OSS}

10¹

0 10 20 30 40 V_{DS} (V)

Figure 9: Normalized on-resistance vs temperature

R_{DS(on)} GIPG1012150D48A1LRON
(norm.)

1.6

1.4

1.2

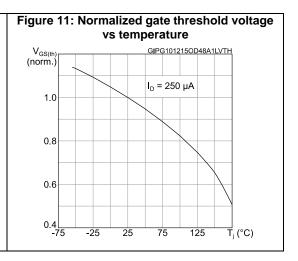
1.0

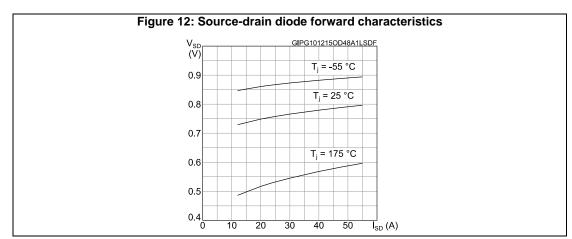
0.8

0.6

-75
-25
25
75
125
T_j (°C)

Figure 10: Normalized V_{(BR)DSS} vs temperature $V_{\text{(BR)DSS}}$ (norm.) $I_D = 250 \ \mu\text{A}$ 1.04 1.00 0.96 0.92 -75 -25 25 75 125 $T_j (^{\circ}\text{C})$





Test circuits STL285N4F7AG

3 Test circuits

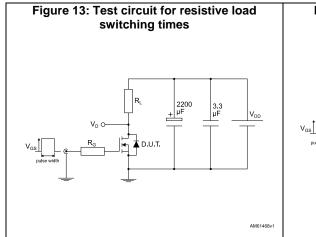


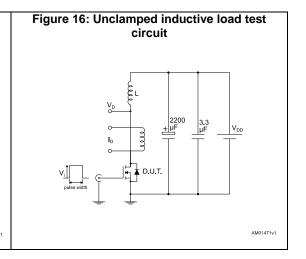
Figure 14: Test circuit for gate charge behavior

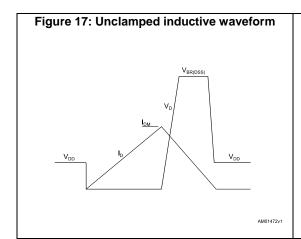
12 V 47 kΩ 100 nF 1 kΩ

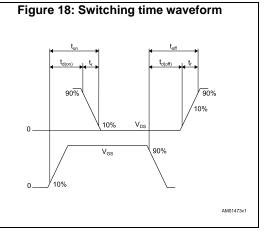
Vos 1 kΩ 1 kΩ

AM01469v1

Figure 15: Test circuit for inductive load switching and diode recovery times







4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 PowerFLAT™ 5x6 WF type C package information

BOTTOM VIEW D6 D3 5 6 E7 E3 E2 Detail A E3 Scale 3:1 80.0 D5(x4) L(x4) b(x8) e(x6) D4 SIDE VIEW A Detail ŏ TOP VIFW 8231817_WF_typeC_r14

Figure 19: PowerFLAT™ 5x6 WF type C package outline

Table 8: PowerFLAT™ 5x6 WF type C mechanical data

Table 8: PowerFLAT™ 5x6 WF type C mechanical data				
Dim.		mm		
Dilli.	Min.	Тур.	Max.	
А	0.80		1.00	
A1	0.02		0.05	
A2		0.25		
b	0.30		0.50	
С	5.80	6.00	6.10	
D	5.00	5.20	5.40	
D2	4.15		4.45	
D3	4.05	4.20	4.35	
D4	4.80	5.00	5.10	
D5	0.25	0.40	0.55	
D6	0.15	0.30	0.45	
е		1.27		
Е	6.20	6.40	6.60	
E2	3.50		3.70	
E3	2.35		2.55	
E4	0.40		0.60	
E5	0.08		0.28	
E6	0.20	0.325	0.45	
E7	0.85	1.00	1.15	
E9	4.00	4.20	4.40	
E10	3.55	3.70	3.85	
K	1.05		1.35	
L	0.90	1.00	1.10	
L1	0.175	0.275	0.375	
θ	0°		12°	

Figure 20: PowerFLAT™ 5x6 recommended footprint (dimensions are in mm)

4.2 PowerFLAT™ 5x6 packing information

Figure 21: PowerFLAT™ 5x6 WF tape (dimensions are in mm)

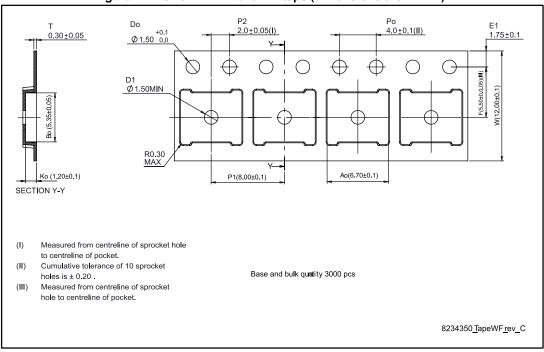
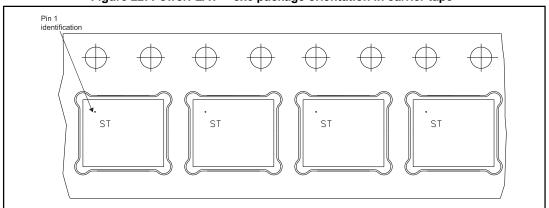


Figure 22: PowerFLAT™ 5x6 package orientation in carrier tape



PART NO.

R25.00

R25.

Figure 23: PowerFLAT™ 5x6 reel (dimensions are in mm)



Revision history STL285N4F7AG

5 Revision history

Table 9: Document revision history

Date	Revision	Changes	
10-Dec-2015	1	First release.	
09-Jun-2016	2	Modified: title Modified: Table 4: "On /off states" Updated: Figure 7: "Static drain-source on-resistance" Minor text changes	

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